

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/723,139	<b>Applicant(s)/Patent under Reexamination</b> RICK ET AL.
	<b>Examiner</b> R. Stephen Dildine	<b>Art Unit</b> 2133

# SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB (text search, see Search History printout)	7/19/2006	RSD
IEEEExplore	7/19/2006	RSD
Update all above	2/26/2007	RSD
Inventors' Name search	7/14/2006	RSD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Text search, see Search History printout		2/26/2007	RSD